Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/807,756	SHIN ET AL.		
Examiner	Art Unit		
James Mackey	1722		

SEARCHED			
Class	Subclass	Date	Examiner
425	171,192R, 451.2,589, 590,595	5/27/2006	JPM
above up	dated	10/16/06	gm
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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PGPub tex (see search	t search h printout)	10/16/06	gm

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Conducted INVENTOR name search in IFW	5/27/2006	JPM
Conducted EAST text search (see search printout)	5/27/2006	JPM